

dN/dx Reconstruction with Machine Learning for Drift Chamber

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1. Introduction

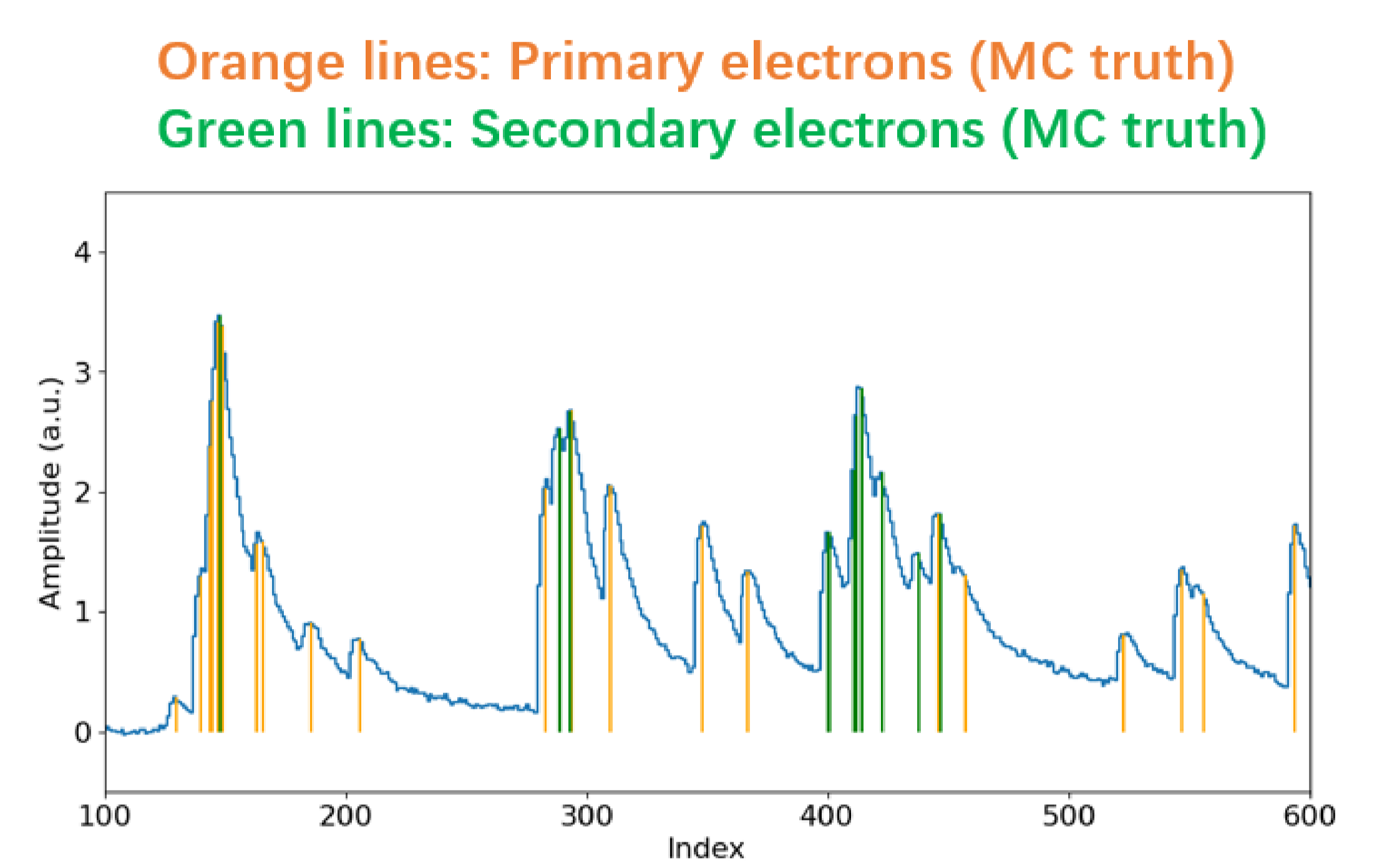
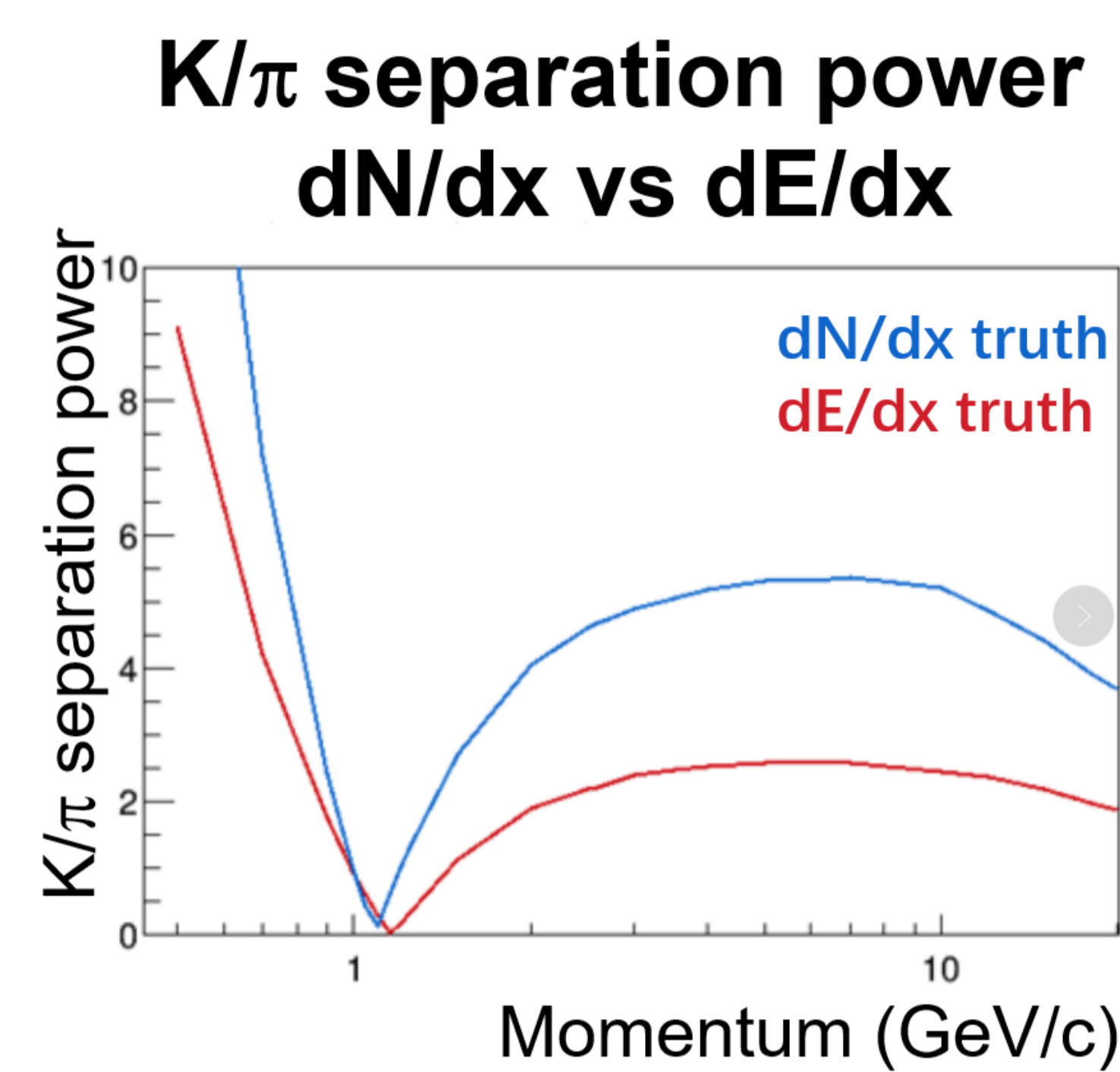
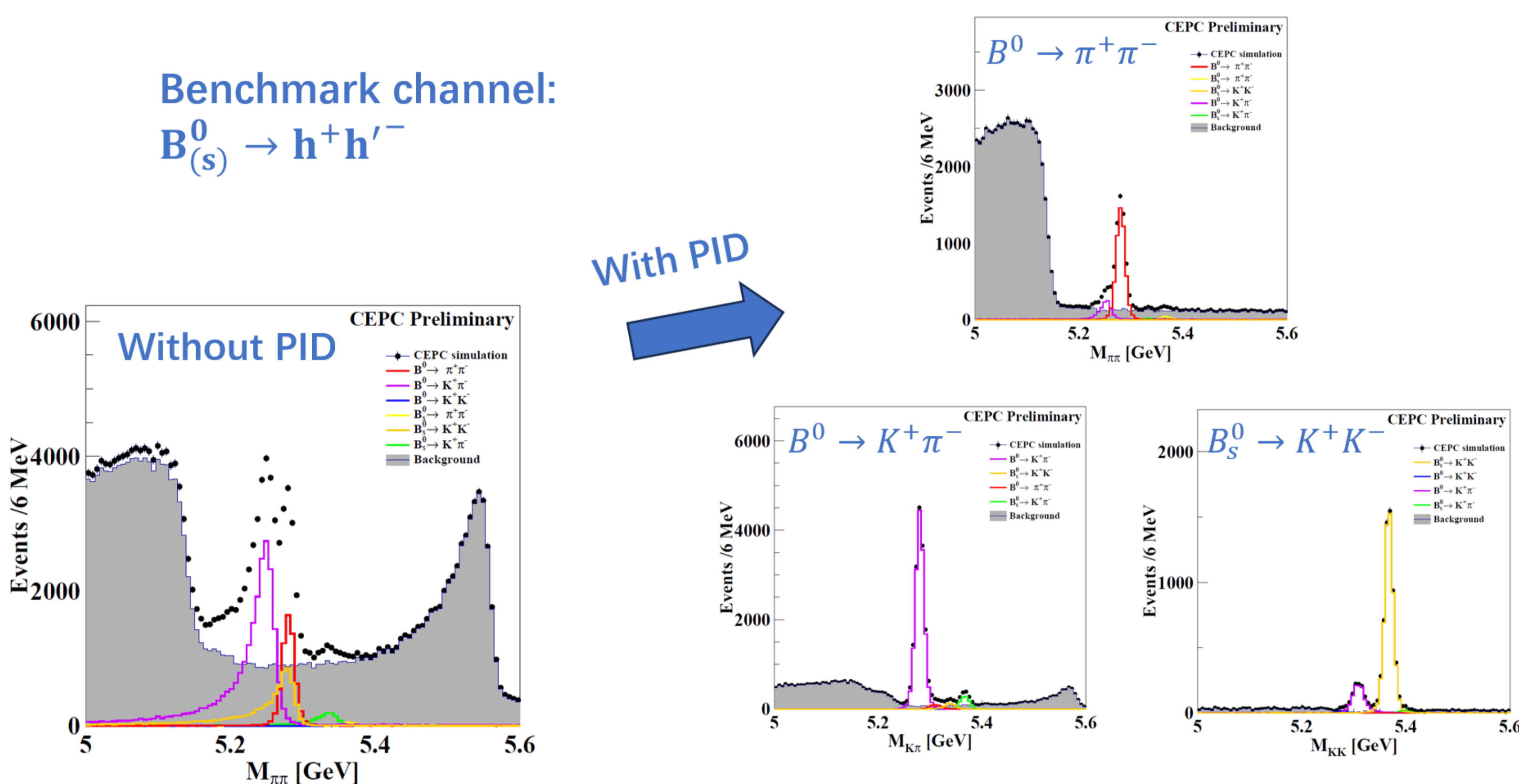
1.1 Cluster counting (dN/dx) as a breakthrough in PID techniques

- PID is essential for flavor physics in future large collider experiments
- Suppressing combinatorics
- Distinguishing between same topology final-states
- Adding valuable additional information

- Drift chamber with cluster counting (dN/dx) could provide powerful PID
- Poisson distributed → No tails
- Small fluctuation → Potentially improve the resolution (from dE/dx) by a factor of 2

1.2 dN/dx reconstruction

- Determine the # of **primary electrons** in the waveform



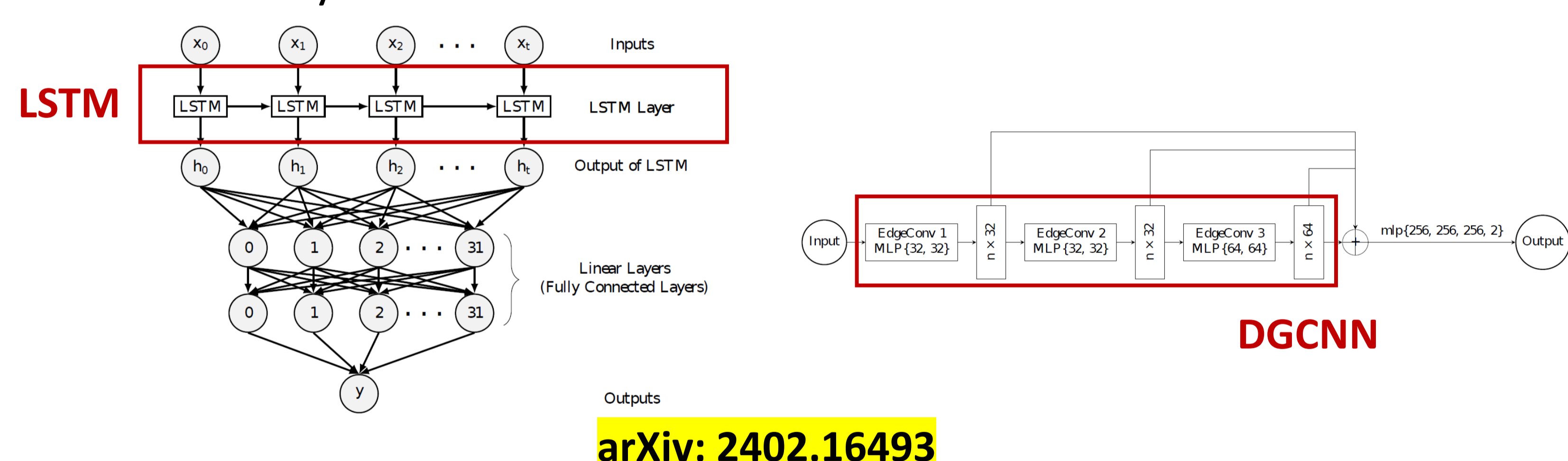
2. Supervised model

2.1 LSTM-based peak finding

- **LSTM**: A specified recurrent neural network (RNN) that deals with the vanishing gradient problem; Can handle long sequences efficiently
- **Peak-finding**: Waveform as sliding windows; Binary classification of signals and noises

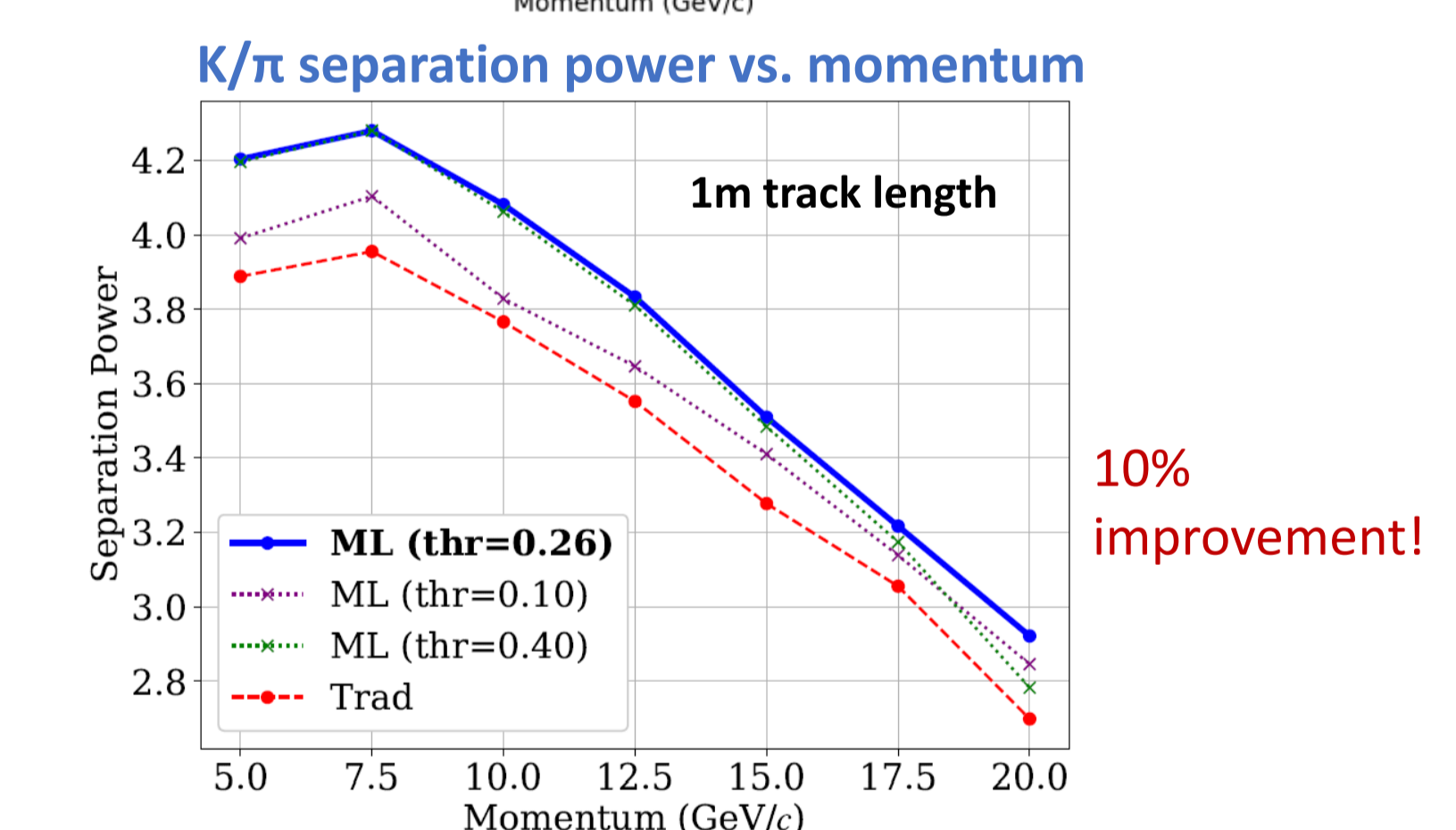
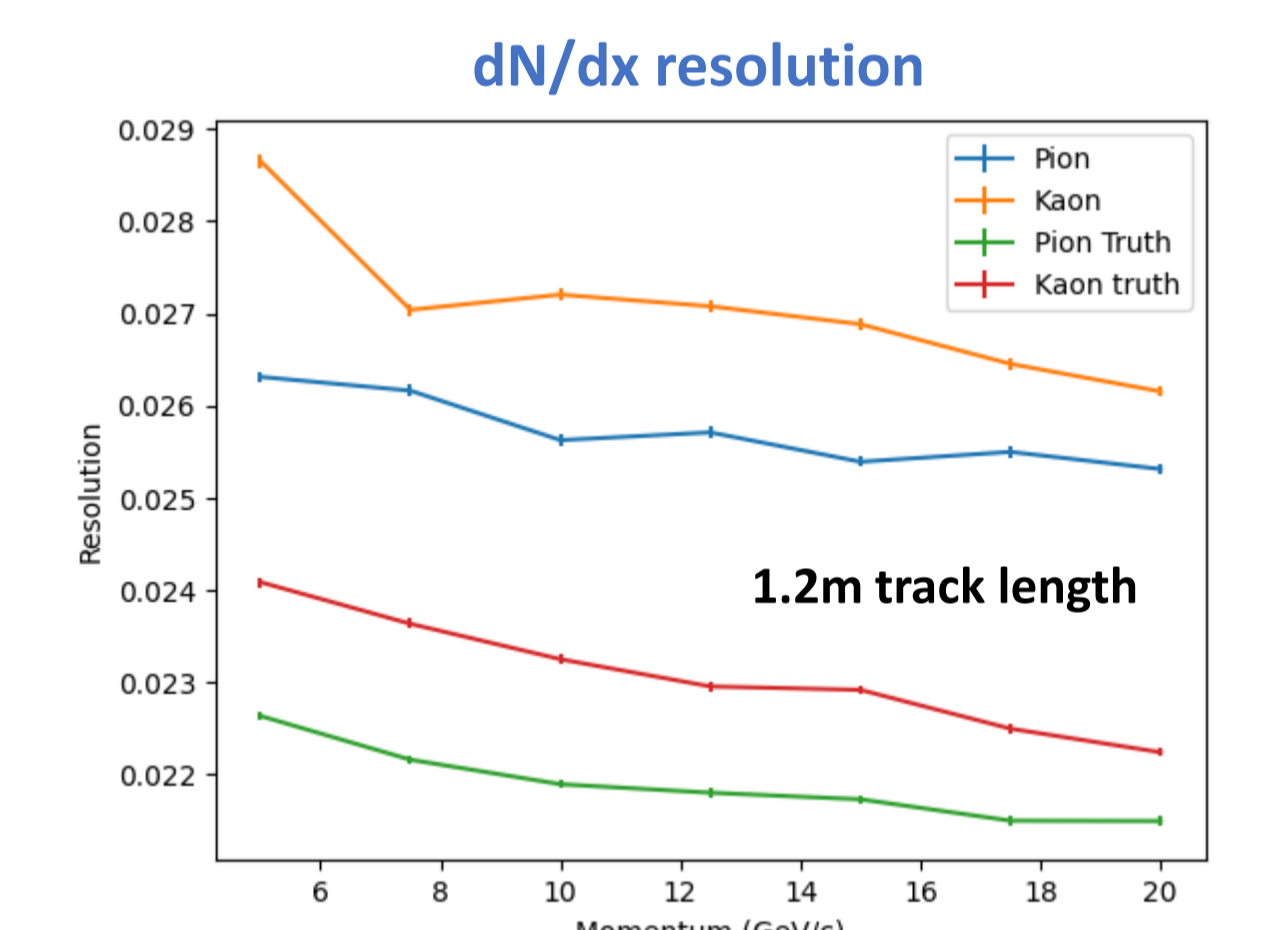
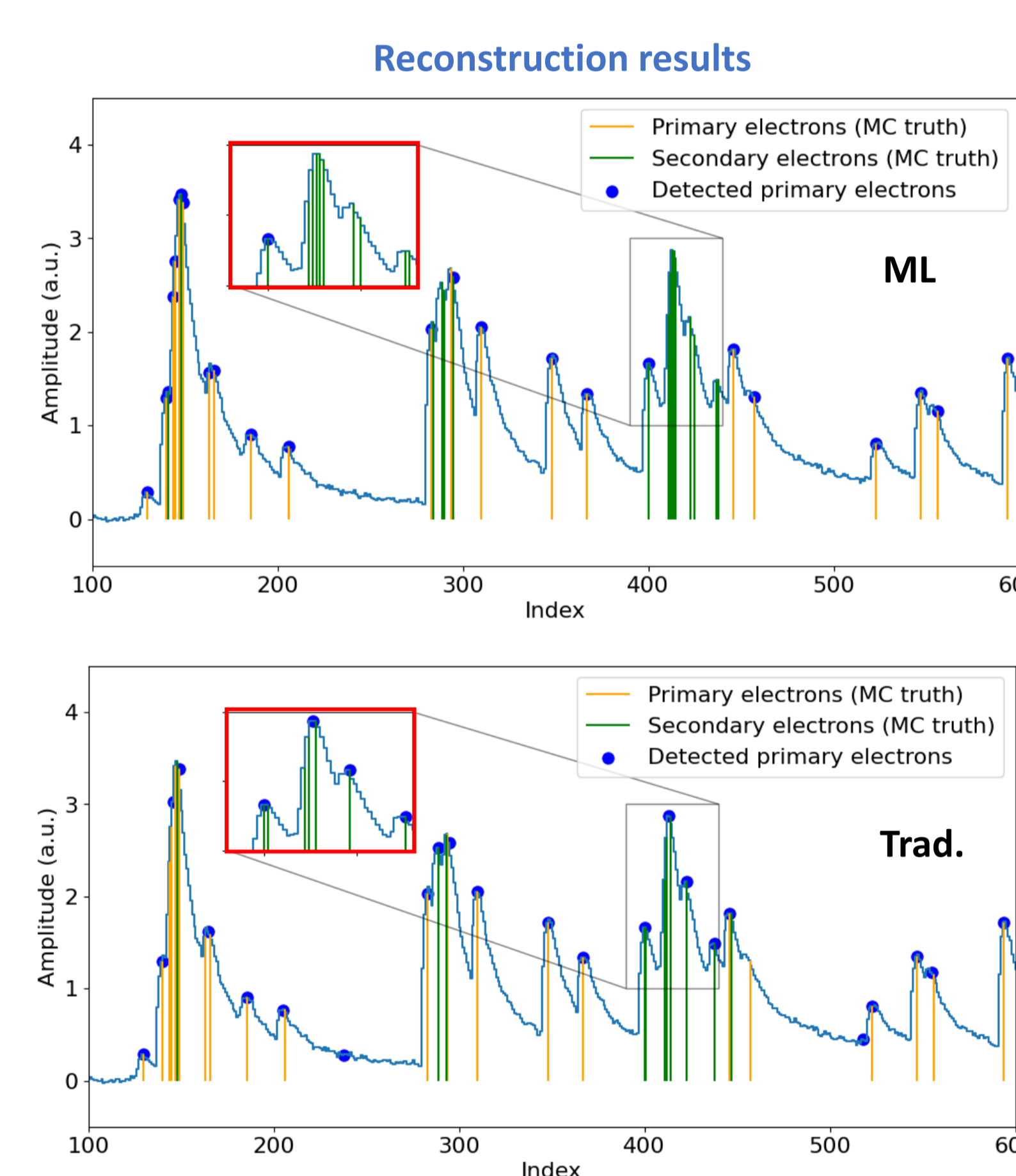
2.2 DGCNN-based clusterization

- **DGCNN**: A specified graph neural network (GNN) that incorporates local information and stacked to learn global properties, which is very suited for clusterization
- **Clusterization**: Peak timing as the node feature. Edges are initially connected by timing similarity; Binary classification of primary and secondary electrons



2.3 PID performance

- Supervised model is more efficient for pile-up detection and secondary electrons removal
- Supervised model has a **10% improvement** for K/pi separation
- **dN/dx resolution is less than 3%** for high momentum K/pi



3. Semi-supervised domain adaptation

3.1 Challenges for applying supervised model on real data

- Imperfect simulation
- Incomplete labels in real data

3.2 Solution: Domain adaptation

- Transfer knowledge between simulation and real data domain via optimal transport

Loss for labeled samples in source domain

$$\min_{f,g} \left[\sum_{i=1}^m L_s(y_i^s, f(g(x_i^s))) + \frac{1}{m_t} \sum_{i=1}^{m_t} L_t(y_i^t, f(g(x_i^t))) + \min_{\gamma \in \Delta} \sum_{i,j} \gamma_{ij} \left(\alpha \|g(x_i^s) - g(x_j^t)\|^2 + \lambda_t L_t(y_i^t, f(g(x_j^t))) \right) \right]$$

Loss for labeled samples in target domain (THIS WORK)

Cost of feature differences between source and target

Cost of 'label' differences between source and target

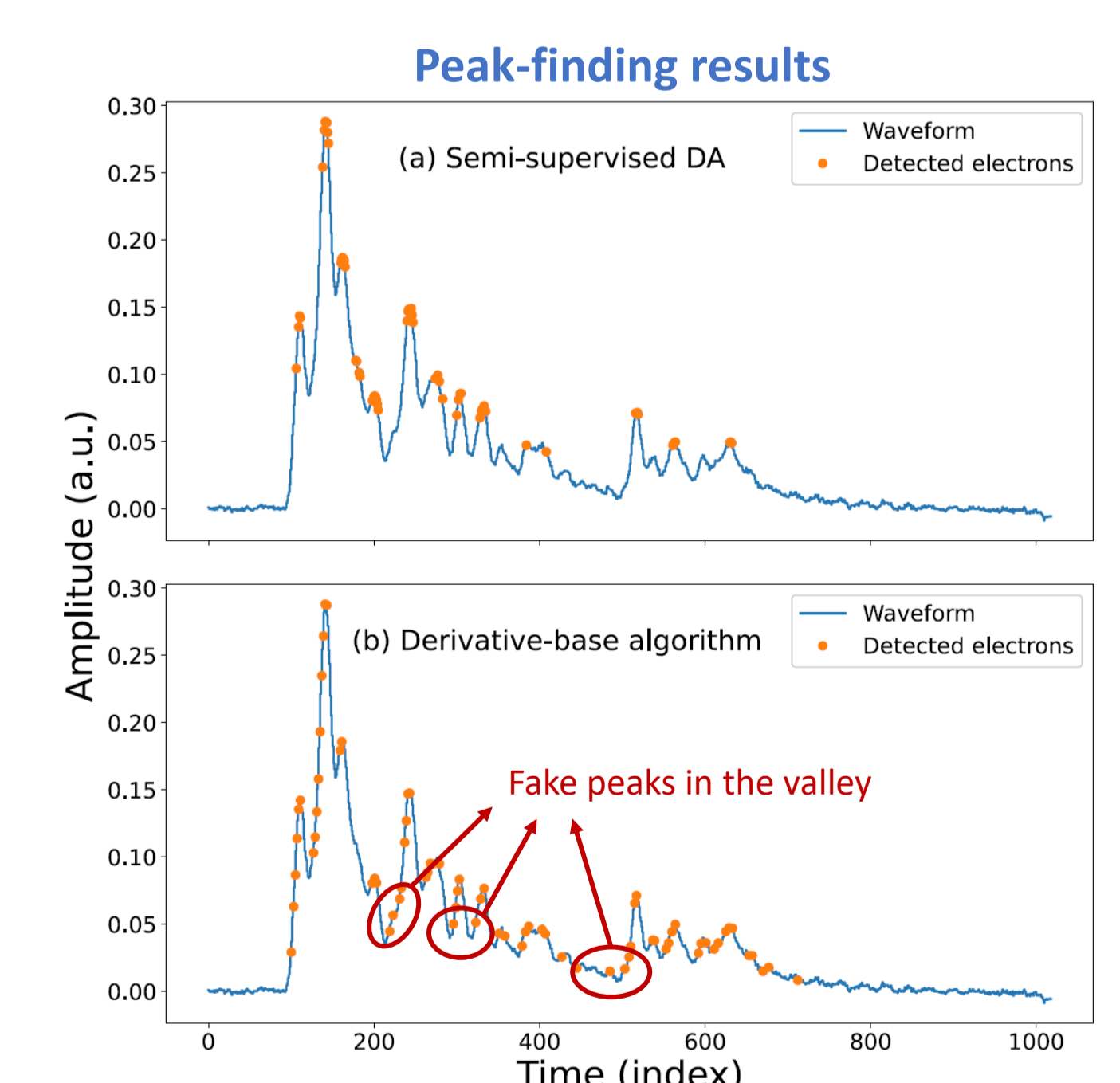
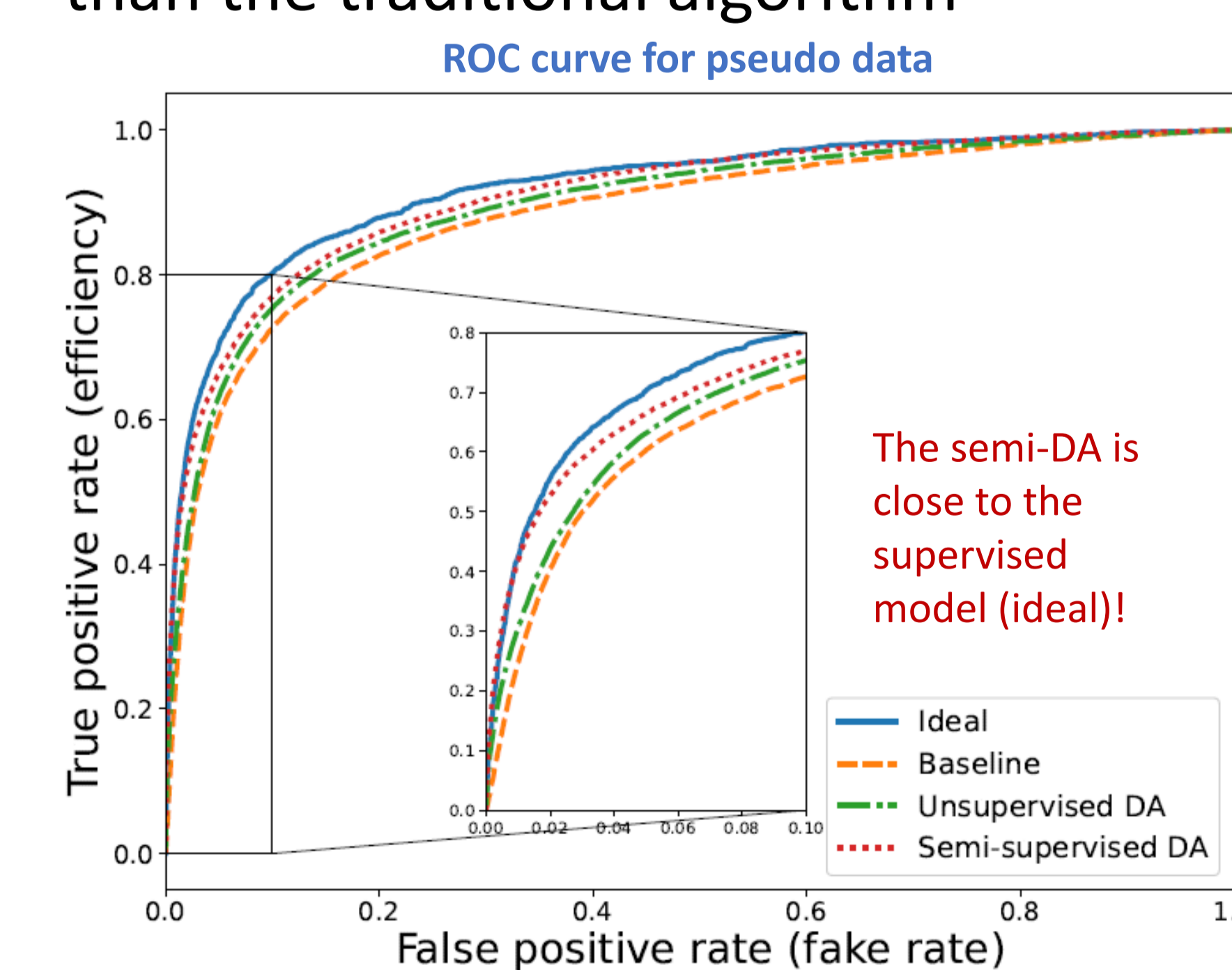
Cost of joint feature-label distribution for OT

Semi-supervised domain adaptation

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3.3 Results

- Validated by pseudo data (Performance close to supervised model)
- Applying to the **CERN testbeam data**, the DA model is more powerful than the traditional algorithm



4. Conclusion

- For simulated samples, the supervised model has **10% improvement** on K/pi separation w.r.t. traditional algorithm.
- For testbeam data, the semi-supervised domain adaptation model **successfully transfers information from simulation** and achieves stable performances.

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